| Search Notes | | | |
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| Application | /Control | No. |
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Applicant(s)/Patent under Reexamination

09/727,491

Examiner

Art Unit

CHEN ET AL.

Cong-Lac Huynh

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| SEARCHED | | | | |
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| Class | Subclass | Date | Examiner | |
| 715 | 500.1 | 11/30/2005 | CLH | |
| | 723 | 11/30/2005 | CLH | |
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